High-Current Event Testing

**Summary of Attempts to Re-create a High Current Event:**
- Injected +/- pulses (>2.5V) into amplifier chain (into_amp node): output always clamped to [-1V, 2.5V]
- Pushed into_mux node to [-10V, 10V]: output always clamped to [-1V, 2.5V]
- Did same to ASIC pin directly (into ASIC node) with RK2 removed:
  - Output followed input, but burned out ASIC channel above +8.75V
- High current events strongly correlated with HV power supply trips